

# DIM2400ESM17-A000

# **Single Switch IGBT Module**

Replaces DS54447-5

DS5447-6 June 2012 (LN29603)

## **FEATURES**

- 10µs Short Circuit Withstand
- High Thermal Cycling Capability
- Non Punch Through Silicon
- Isolated AlSiC Base with AlN Substrates
- Lead Free construction

## **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers
- Traction Drives

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 1200V to 6500V and currents up to 2400A.

The DIM2400ESM17-A000 is a single switch 1700V, n-channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

## **ORDERING INFORMATION**

Order As:

## DIM2400ESM17-A000

Note: When ordering, please use the complete part number

#### **KEY PARAMETERS**

$V_{CES}$		1700V
V <sub>CE(sat)</sub>	* (typ)	2.7V
l <sub>c</sub> ` ´	(max)	2400A
I <sub>C(PK)</sub>	(max)	4800A

<sup>\*</sup> Measured at the power busbars, not the auxiliary terminals

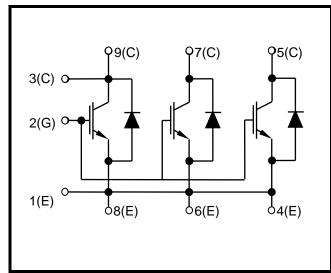


Fig. 1 Circuit configuration



Fig. 2 Package



## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0V	1700	V
$V_{GES}$	Gate-emitter voltage		±20	V
I <sub>C</sub>	Continuous collector current	T <sub>case</sub> = 75°C	2400	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 110°C	4800	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	20800	W
l <sup>2</sup> t	Diode I <sup>2</sup> t value	$V_R = 0$ , $t_p = 10$ ms, $T_j = 125$ °C	1080	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	4000	V
$Q_{PD}$	Partial discharge – per module	IEC1287, V <sub>1</sub> = 1800V, V <sub>2</sub> = 1300V, 50Hz RMS	10	рС

## THERMAL AND MECHANICAL RATINGS

Internal insulation material:

Baseplate material:

Creepage distance:

Clearance:

CTI (Comparative Tracking Index):

AIN

AISiC

33mm

20mm

600

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor	Continuous dissipation - junction to case	-	-	6	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode	Continuous dissipation - junction to case	-	-	13	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	6	°C/kW
T <sub>j</sub>	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
	Screw torque	Mounting – M6	-	-	5	Nm
		Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm



## **ELECTRICAL CHARACTERISTICS**

 $T_{case}$  = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
	Collector cut-off current	$V_{GE} = 0V$ , $V_{CE} = V_{CES}$			3	mA
I <sub>CES</sub>		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$ °C			75	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			12	μΑ
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_C = 120$ mA, $V_{GE} = V_{CE}$	4.5	5.5	6.5	V
\ \ \ †	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 2400A		2.7	3.2	V
V <sub>CE(sat)</sub> †		V <sub>GE</sub> = 15V, I <sub>C</sub> = 2400A, T <sub>j</sub> = 125°C		3.4	4.0	V
I <sub>F</sub>	Diode forward current	DC			2400	Α
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms			4800	Α
\/ †	Diode forward voltage	I <sub>F</sub> = 2400A		2.2	2.5	V
$V_F^{\dagger}$		I <sub>F</sub> = 2400A, T <sub>j</sub> = 125°C		2.3	2.6	V
C <sub>ies</sub>	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		180		nF
$Q_g$	Gate charge	±15V		27		μC
C <sub>res</sub>	Reverse transfer capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$				nF
L <sub>M</sub>	Module inductance			10		nΗ
R <sub>INT</sub>	Internal transistor resistance			90		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$T_{j} = 125^{\circ}C$ , $V_{CC} = 1000V$ $t_{p} \le 10\mu s$ , $V_{GE} \le 15V$ $V_{CE (max)} = V_{CES} - L^{*}x dI/dt$ IEC 60747-9		9600		А

 $<sup>^{\</sup>dagger}$  Measured at the power busbars, not the auxiliary terminals  $^{\star}$  L is the circuit inductance +  $L_{\rm M}$ 



## **ELECTRICAL CHARACTERISTICS**

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time	$I_{C} = 2400A$ $V_{GF} = \pm 15V$		2000		ns
t <sub>f</sub>	Fall time			200		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{GE} = \pm 13V$ $V_{CE} = 900V$		900		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 1.0\Omega$ $R_{G(OFF)} = 1.0\Omega$ $L_S \sim 50 \text{nH}$		800		ns
t <sub>r</sub>	Rise time			300		ns
E <sub>ON</sub>	Turn-on energy loss			475		mJ
$Q_{rr}$	Diode reverse recovery charge	$I_F = 2400A$ $V_{CE} = 900V$ $dI_F/dt = 8500A/\mu s$		450		μC
I <sub>rr</sub>	Diode reverse recovery current			1200		Α
E <sub>rec</sub>	Diode reverse recovery energy			300		mJ

## $T_{case}$ = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time			2300		ns
t <sub>f</sub>	Fall time	$I_{C} = 2400A$ $V_{GF} = \pm 15V$		250		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 900V$		1200		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 1.0\Omega$ $R_{G(OFF)} = 1.0\Omega$ $L_{S} \sim 50 \text{nH}$		900		ns
t <sub>r</sub>	Rise time			300		ns
E <sub>ON</sub>	Turn-on energy loss			750		mJ
$Q_{rr}$	Diode reverse recovery charge	$I_F = 2400A$ $V_{CE} = 900V$ $dI_F/dt = 8000A/\mu s$		750		μC
I <sub>rr</sub>	Diode reverse recovery current			1400		Α
E <sub>rec</sub>	Diode reverse recovery energy			600		mJ



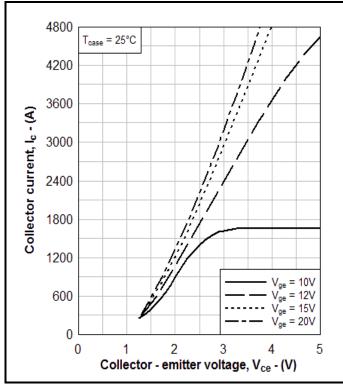


Fig. 3 Typical output characteristics

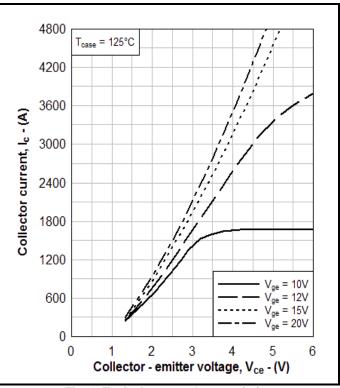


Fig. 4 Typical output characteristics

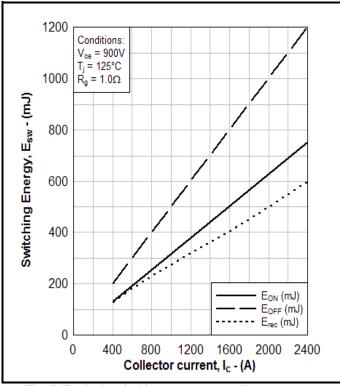


Fig. 5 Typical switching energy vs collector current

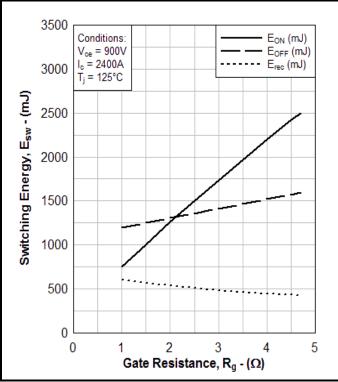


Fig. 6 Typical switching energy vs gate resistance



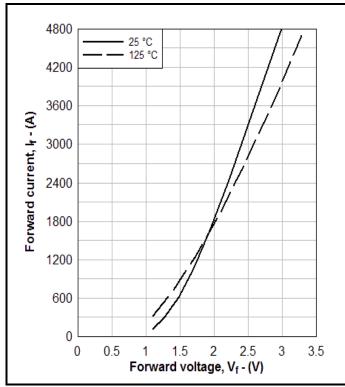


Fig. 7 Diode typical forward characteristics

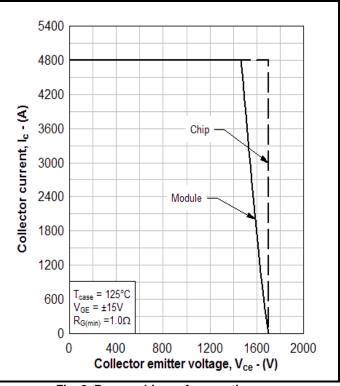


Fig. 8 Reverse bias safe operating area

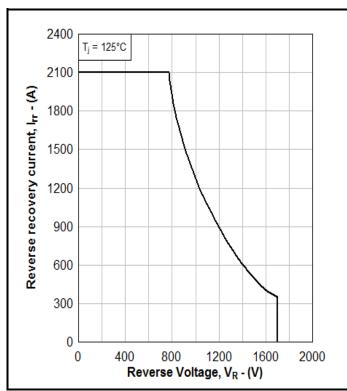


Fig. 9 Diode reverse bias safe operating area

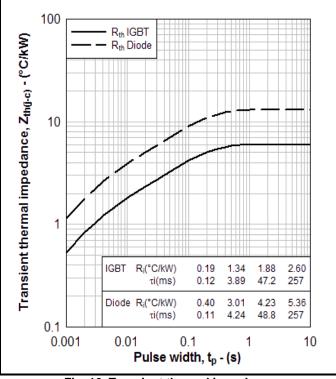


Fig. 10 Transient thermal impedance



## **PACKAGE DETAILS**

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise.

## DO NOT SCALE.

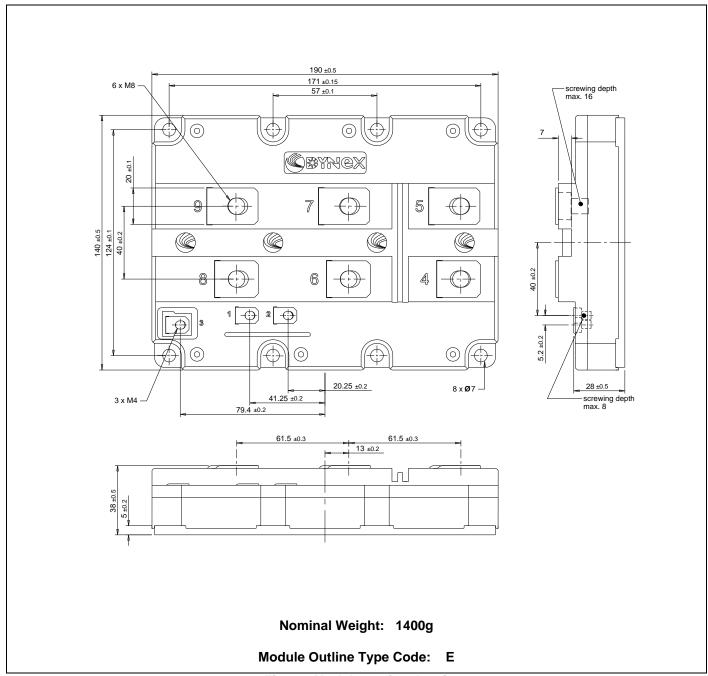


Fig. 11 Module outline drawing



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